

# Comb Line Notch Filter Design on Silicon Coplanar Transmission Line

Buddhadev Pradhan, Bhaskar Gupta

**Abstract** - A comb line notch filter is presented, in which two quarter wave length resonators are placed face to face on the signal line of a CPW. The CPW is designed on silicon substrate enabling compatibility with planar IC technology. The comb line notch filter rejection frequency is 12.75GHz, where the return loss is -1.7dB and insertion loss is -3.8dB. This proposed structure is simulated using ANSOFT HFSS v13®.

**Keywords** – Comb line, notch filter, coplanar technology, CMOS technology, RF characterization.

## I. INTRODUCTION

Microwave filters are critical components for electronic warfare, radar, and communications systems. But typical filters are bulky, expensive, and consume large amounts of power [1]. Under such circumstances, we have proposed a comb line filter equipped with two quarter-wavelength simple resonators [4]. This filter had such a structure that the resonators are placed face-to-face on signal line of a CPW transmission line, leading to tight coupling between these resonators. This feature gave great advantages to this filter that any additional lumped elements were not needed to enhance the coupling.

low loss, high power and reduced size may also be achieved. In this paper, we present a comb line embedded CPW transmission line on silicon substrate. To the best of our knowledge, no such design has been carried out on silicon substrate to allow CMOS compatibility at such high frequency ranges.

The comb line is etched on the signal strip of the CPW which enables the structure to behave as a notch filter, that reject only 12.75GHz frequency. The proposed structure is simulated using ANSOFT HFSS v13®. We also suggest an equivalent circuit model of a comb line filter, which not only provides an insight into the system but also helps in its optimization.

## II. PROPOSED DEVICE STRUCTURE

Figs.1(a) and 1(b) illustrate the top view and cross section of a comb line notch filter embedded CPW transmission line. A CPW configuration corresponding to W/S/W of 60/100/60 is chosen to obtain 50ohm characteristic impedance. The comb line quarter-wavelength resonators are patterned on the CPW central line which is housed on an oxidized high resistivity silicon substrate whose relative permittivity is 11.9, thickness is 275µm and width & length are 820µm and 4000µm respectively.

The CPW transmission line is made of Au (1µm thick) with loaded comb line structure. The length and width of the comb line quarter wavelength resonators are given by  $L, T$  and  $c, d$  respectively and the gap between two quarter wavelength resonator is  $b$ .

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As comb line can be implemented by planar IC technology [4], an added advantage of CMOS compatibility along with

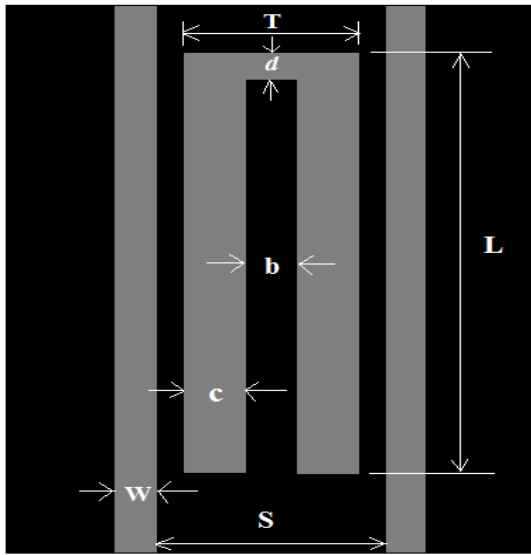
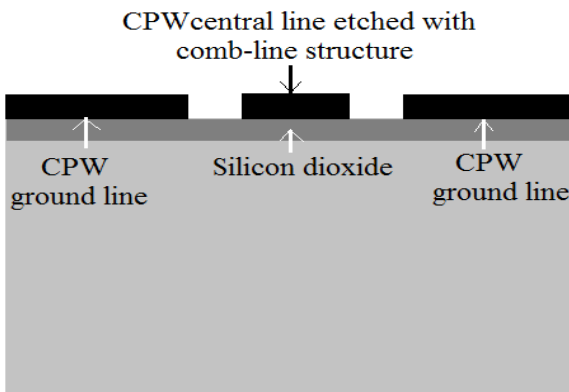


Fig. 1(a): Top view of a comb line structure loaded CPW transmission line.



- Silicon substrate (275µm)
- Silicon dioxide (1µm)
- Gold (Au)
  - (i) CPW ground planes (1µm).
  - (ii) CPW central plane loaded with comb-line structure (1µm).

Fig. 1(b): Cross sectional view of the comb line structure loaded CPW transmission line.

### III. PROPOSED DEVICE DESIGN

The schematic diagram of a comb line filter and CPW loaded transmission-line equivalent-circuit network is given in Figs.2(a)&(b), where  $Y_r$  is the characteristic admittance of the lines,  $C_r$  is the capacitance value of the

lumped capacitors and  $Y_c$  is the characteristic admittance of the distributed inductor modelling the coupling between resonators.

$$Y_r = 1/j\omega L_r \text{----- (1)}$$

$$Y_c = 1/j\omega L_c \text{----- (2)}$$

As shown, the filter is made up of two identical transmission-line segments shortened to ground in one extreme and terminated in a lumped capacitor at the opposite end. The line-capacitor combination corresponds to the filter resonator, modelled as a parallel connection of the corresponding capacitor and the equivalent distributed inductor of the transmission-line segment. The coupling between the resonator lines is inductive, and is approximated as a series distributed inductor connecting the resonators. A distributed inductor refers to a transmission line shortened at one extreme, exhibiting an equivalent admittance [5]

$$Y_{eq} = Y_0 / \tan\theta \text{----- (3)}$$

where  $Y_0$  is the characteristic admittance

$$\theta = (2\pi l / \sqrt{\epsilon_{eff}} / c) f \text{----- (4)}$$

where  $\theta$  is the electrical length of the line.

This design starts by selecting a suitable CPW for obtaining 50ohm characteristic impedance ( $Z_0$ ). Here we report a single rectangular shaped comb line resonator etched onto the signal line of the CPW. The length of the comb line resonator ( $L$ ) is very crucial for obtaining proper filtering actions. For a center rejection frequency of 12.75 GHz it is seen that the length of the resonator ( $L$ ) would be around 2000µm according to,

$$L = \lambda_g / 4 \text{----- (5)}$$

where  $\lambda_g$  is the guided wavelength and is given by

$$\lambda_g = \lambda_0 / \sqrt{\epsilon_{eff}} \text{----- (6)}$$

where  $\epsilon_{eff}$  is the effective permittivity and is approximately given by

$$\epsilon_{eff} = (\epsilon_r + 1) / 2 \text{----- (7)}$$

where  $\epsilon_r$  is the relative permittivity of the substrate which is 11.9 for silicon.

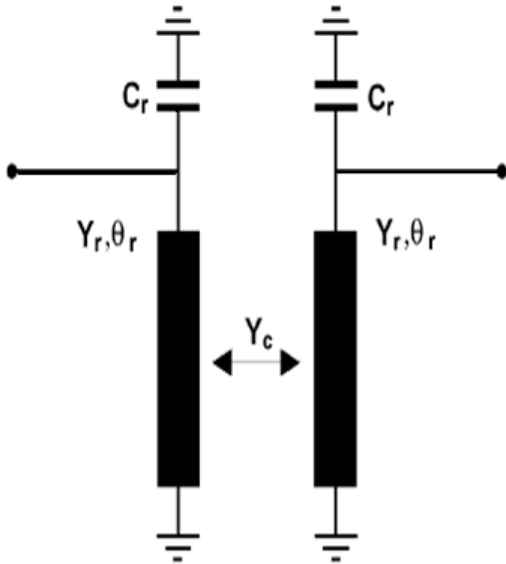


Fig.2.(a) Comb line filter schematic diagram .

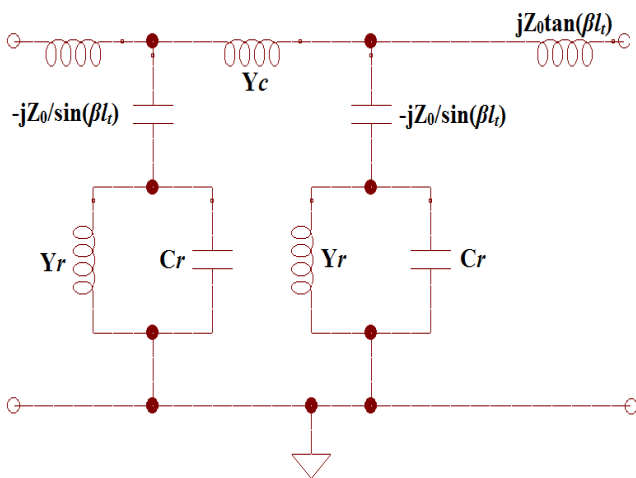


Fig.2.(b).Comb line filter CPW loaded transmission-line equivalent circuit network.

The proposed device structure has been simulated using standard FEM tools and the results are discussed in the following section.

#### IV. RESULTS AND DISCUSSIONS

#### RF Characterization :-

The choice of the dimensions for the comb line resonators is very crucial for obtaining the desired performance. As already discussed the length & width of the comb line resonator are chosen as  $2000\mu\text{m}$  and  $80\mu\text{m}$ . Varying the comb line resonator width ('c' & 'd') we observed the rejection notch frequency. This has been validated with the help of the proposed model and FEM simulation using ANSOFT- HFSS v13®. Figs. 3(a) & (b) show the simulated S-parameters for the Comb line notch filter with varying 'c' & 'd'. These simulation results show very good rejection around -32 dB when  $c=20\mu\text{m}$  &  $d=30\mu\text{m}$ . Fig.4 shows the result for S-parameters comb line filter for the optimal case of  $c=20\mu\text{m}$  and  $d=30\mu\text{m}$ . High rejection for the optimal notch filter is shown at 12.75 GHz notch frequency with a return loss of around -1.7dB .

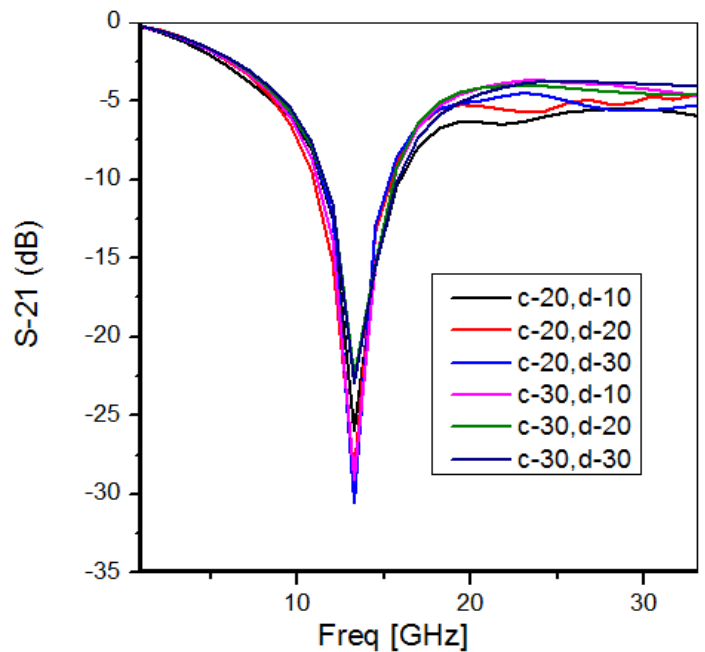


Fig. 3.(a) comb line notch filter HFSS-simulation S-21 result for variation of comb-line resonators width-'c' & 'd'.

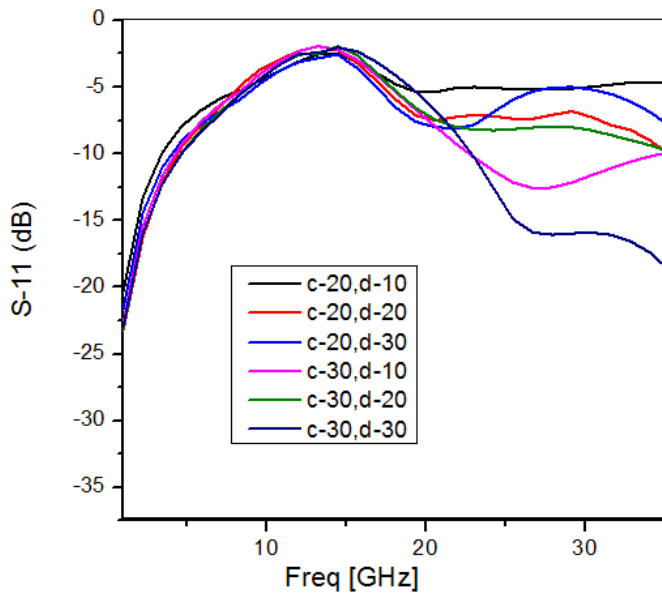


Fig.3.(b) comb line notch filter HFSS-simulation S-11 result for variation of comb-line resonators width-'c' & 'd'.

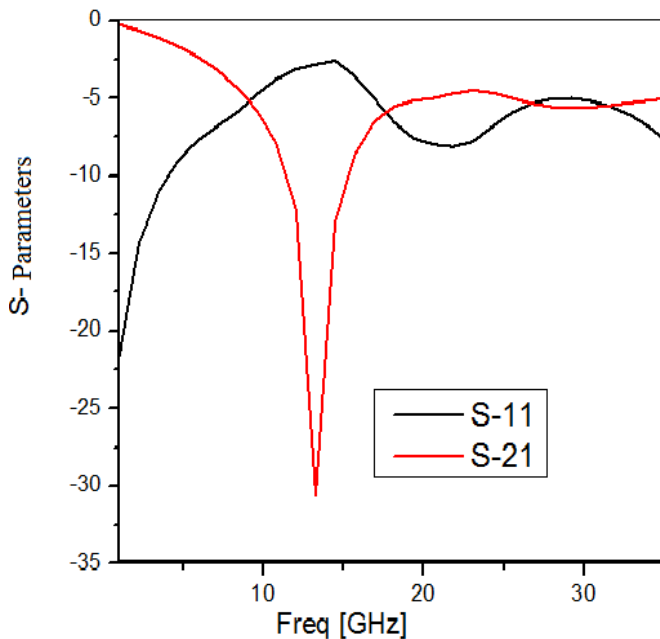


Fig.4. comb line notch filter HFSS-simulation results for variation of resonator width  $c=20, d=30$

## V. CONCLUSIONS

In this paper, we propose a comb line notch filter as the first demonstration of using planer IC technology on silicon

substrate. With its high rejection frequency and compact size, this filter is promising for applications in microwave communications and radars. Further work is going on to improve the loss performance. Work is also in progress to achieve tuneability in the filter by using MEMS bridge.

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## REFERENCES

1. Vincze, A.D. 'Practical design approach to microstrip combline filters', IEEE Trans. Microw. Theory Tech., 1974, 22, pp. 1171-1181.
2. Brown, E.R.: "RF-MEMS switches for reconfigurable integrated Circuits", IEEE Trans. Microw. Theory Tech., 1998, 46, pp. 1868-1880.
3. Gabriel M. Rebeiz, "RF MEMS: Theory, Design, and Technology", John Wiley & Sons Ltd, Chapters 1, 9 and 10, pp.1-20, 259-324, 2003.
4. YASUSHI HORII Faculty of Informatics, Kansai University 2-1-1 Ryozenji-cho, Takatsuki-shi, Osaka 569-1095 Japan, TOSHIKI KITAMURA, MASAHIRO GESHIRO, SHINNOSUKE SAWA Osaka Prefecture University 1-1 Gakuen-cho, Sakai-shi, Osaka 599-853 1 Japan. "MULTISTAGE DUAL-PLANE COMB-LINE FILTER EXCITED BY CONDUCTOR-BACKED COPLANAR WAVEGUIDE."
5. Manuel Sánchez-Renedo, Roberto Gómez-García, Student Member, IEEE, José I. Alonso, Member, IEEE, and César Briso-Rodríguez "Tunable Combline Filter With Continuous Control of Center Frequency and Bandwidth."
6. Isak Reines, Andrew Brown, Mohammed El-Tanani, Alex Grichener and Gabriel Rebeiz, "1.6-2.4 GHz RF MEMS 3-Pole Suspended Combline Filter", University of California San Diego La Jolla, Ca 92121 A. Brown Design 46055 Bloomcrest Dr. Northville, MI 48167.
7. K. Hirano, S. Nishimura, and S. K. Mitra, "Design of digital notch filters," IEEE Trans. Circuits Syst., vol. CAS-21, pp. 540-546, July 1974.

8. I. C. Hunter *et al.*, "Microwave filters—Applications and technology," *IEEE Trans. Microw. Theory Tech.*, vol. 50, no. 3, pp. 794–805, Mar. 2002.

9. T. Ishizaki, T. Uwano, and H. Miyake, "An extended configuration of a stepped impedance comb-line filter," *IEICE Trans. Electron.*, vol. E79-C, no. 5, pp. 671–678, May 1996

10. M. Sagawa, M. Makimoto, and S. Yamashita, "Geometrical structures and fundamental characteristics of microwave stepped-impedance resonators," *IEEE Trans. Microwave Theory Tech.*, vol. 45, pp. 1078–1085, July 1997.

11. Tian-Hu Yu, S.K. Mitra and H. Babic, "Design of Linear Phase FIR Notch Filters", *Sadhana*, Vol. 15, Iss.3, pp. 133-55, Nov. 1990, India

12. S. J. Park, K. Y. Lee, and G. M. Rebeiz, "Low-loss 5.15–5.70 GHz RF filter for wireless LAN applications," *IEEE Trans. Microw. Theory Tech.*, vol. 54, no. 11, pp. 3931–3939, Nov. 2006.